



REVISIONS			
REV.	DATE	DESCRIPTION	APD
Specification			
Item No.	TSL-355-18-56		
Wavelength	355nm		
EFL	56mm		
BFL	77.3mm		
WD	73.84mm		
Scan angle	±15°		
Scan length	29mm		
Scan field	18mm×18mm		
Input beam EP	6mm		
M1-M2	18mm		
M2-lens center	19.5mm		
M2-mount edge	14.4mm		
Center spot size(1/e2)	4μm		
Edge spot size(1/e2)	6μm		
Outer diameter D	90mm		
Thread	M85×1		
Total length	35mm		
With protective window	No		
Transmission	>95%		
Series No.			

Notes:

1. Dimensional control is applied after hard anodized coating (black);
2. Remove all sharp edges by deburring before coating;
3. Silk screen clear.

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TOLERANCES UNLESS SPECIFIED: -	NAME	DATE	WAVELENGTH TECHNOLOGY	
SURFACE: Black Anodize	DRAWN	-	30-03-07	DWG. NO. SL064
MATERIAL: AL	CHECKED			
UNIT: mm	TSL-355-18-56		back reflection	REV. A
SCALE:				SHEET: 1 OF 1